

<b>Notice of References Cited</b>	Application/Control No. 10/763,497	Applicant(s)/Patent Under Reexamination VAN DAMME ET AL.	
	Examiner Sin J. Lee	Art Unit 1752	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0091932 A1	05-2003	Loccufier et al.	430/272.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 9-87630	03-1997	Japan	Iwanaga et al.	N/A
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	DERWENT English abstract for JP 9-87630.
	V	Machine-assisted English translation of JP 9-87630, provided by JPO.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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